

Features

- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low R_{DS(on)}
- Easy to parallel
- Simple to drive
- RoHS Compliant

Benefits

- Increased Power Density
- Faster Operating Freequency
- Reduction of Heat Sink Requirements
- Higher Efficiency
- Reduced EMI

Applications

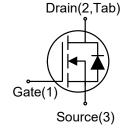
- Power Factor Correction Modules
- Switch Mode Power Supplies
- DC-AC Inverters
- High Voltage DC/DC Converters











Maximum Ratings (T_c = 25 °C unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions
V_{DSmax}	Drain - Source Voltage	650	V	V _{GS} = 0 V, I _D = 100 μA
V_{GSmax}	Gate - Source Voltage (dynamic)	-5/+26	V	AC (f >1 Hz)
V_{GSop}	Gate - Source Voltage (static)	0/+18	V	Static
	Continuous Drain Current	15	Α	T _C = 25°C
I _D	Continuous Diam Current	12		T _C = 100°C
I _{DM}	Pulsed Drain Current	39	А	Pulse width t _P limited by T _{jmax}
В	Power Dissipation	52	w	T _C = 25°C
P_{D}	rowei Dissipation	25	**	T _C = 100°C
T_{J},T_{stg}	Operating Junction and Storage Temperature	-55 to +175	°C	



Electrical Characteristics (T_C = 25°C unless other wise specified)

Static Characteristics

0	Parameter	Took conditions		Unit		
Symbol	Faranteter	Test conditions	Min.	Тур.	Max.	Oilit
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	I _D =1 mA, V _{GS} =0V	650			V
I DSS	Zero Gate Voltage Drain Current	V _{DS} =850V, V _{GS} =0V 1 15				μΑ
GSS	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =18V	50			mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=1$ mA $T_{j}=25$ °C $T_{j}=175$ °C		3.5 2.8	4	V
RDS(on)	Drain-Source On-State Resistance	V _{GS} =18V, I _D =4.5A T _j =25°C T _j =175°C		180 205	220	mΩ
ADS(OII)	Drain-Source On-State Resistance	V_{GS} =15V, I_{D} =4.5A T_{j} =25°C T_{j} =175°C		260 295	300	nA
Ciss	Input Capacitance			180		pF
Coss	Output Capacitance	V _{DS} =400V, <i>f</i> =1MHz, V _{GS} =0V		20		pF
C _{rss}	Reverse Transfer Capacitance			0.9		pF
Q_{g}	Total Gate Charge	V _{DS} =400V, I _D =5A,		11.2		nC
Q_{gs}	Gate to Source Charge	$R_{\rm G} = 10 \ \Omega$ $V_{\rm GS} = 0/15 \text{V}$		2.3		nC
Q_{gd}	Gate to Drain Charge			1.1		nC
$\emph{t}_{ extsf{d}(extsf{on})}$	Turn-On Delay Time			5		ns
t r	Rise Time			17		ns
$t_{\sf d(off)}$	Turn-Off Delay Time	V _{DD} =400V, I _D =5 A, V _{GS} =-5/18 V,		8		ns
t _f	Fall Time	R_{G} =10 Ω ,		10		ns
E on	Turn-On Energy			25		μJ
E _{off}	Turn-Off Energy			10		μJ



Reverse Diode Characteristics

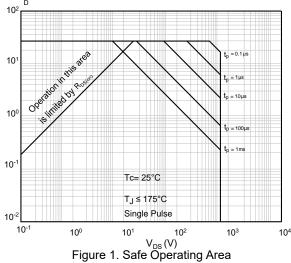
Symbol	Parameter	Test conditions	Value			Unit
Symbol	Farailleter	rest conditions	Min.	Тур.	Max.	Offic
$V_{ m SD}$	Diode Forward Voltage	V _{GS} =-4V, I _{SD} =2.5A T _j =25°C T _j =175°C		4.0 3.6		V
<i>I</i> s	Continuous Diode Forward Current	<i>T</i> _c =25°C <i>T</i> _c =100°C		15 12		А
t rr	Reverse Recovery Time	I _{SD} =-5A V _{GS} =-5V, I _{SD} =4.5A,		50		ns
Q _{rr}	Reverse Recovery Charge	V _R =400V,		38		nC
<i>I</i> rrm	Peak Reverse Recovery Current	di/dt=1000A/μs		2.4		А

Thermal Characteristics

Symbol	Dovementor		llmit		
	Parameter	Min.	Тур.	Max.	Unit
R _{th(j-c)}	Thermal Resistance from Junction to Case		2.88		°C/W
R _{th(j-a)}	Thermal Resistance from Junction to Ambient		40		°C/W



Typical Performance



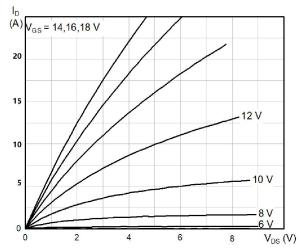


Figure 3. Typical Output Characteristics, T_J = 25°C

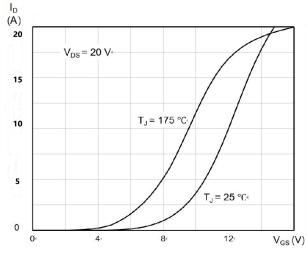
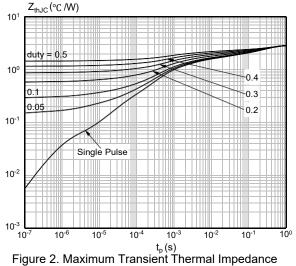


Figure 5 Typical Transfer Characteristics



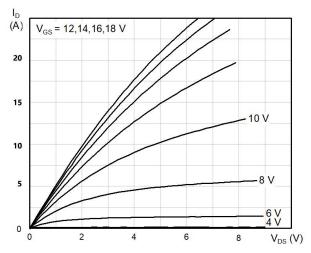


Figure 4. Typical Output Characteristics, T_J = 175°C

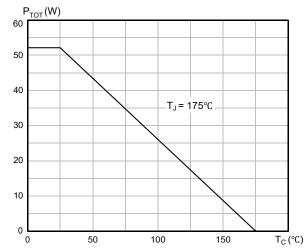


Figure 6. Total Power Dissipation

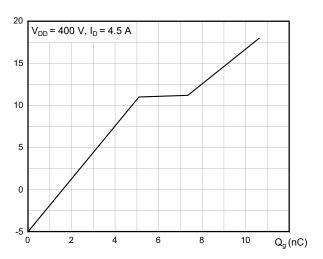


Figure 7. Typical Gate Charge Characteristics

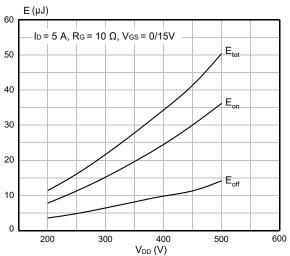


Figure 9. Typical Switching Energy vs. Supply Voltage

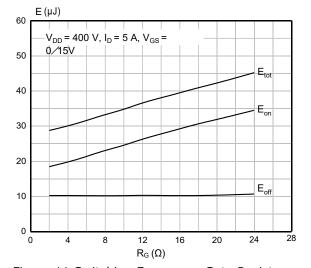


Figure 11.Switching Energy vs. Gate Resistance

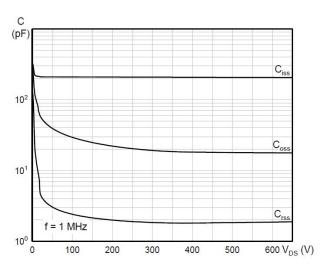


Figure 8. Typical Capacitance Characteristics

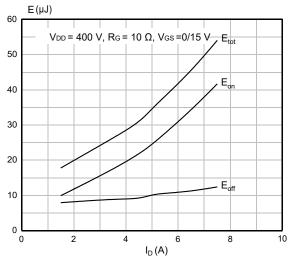


Figure 10. Typical Switching Energy vs. Drain Current

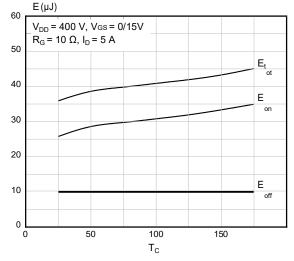


Figure 12. Typical Switching Energy vs. Temperature

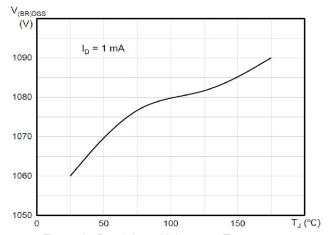


Figure 13. Breakdown Voltage vs. Temperature

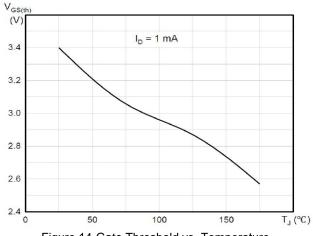


Figure 14. Gate Threshold vs. Temperature

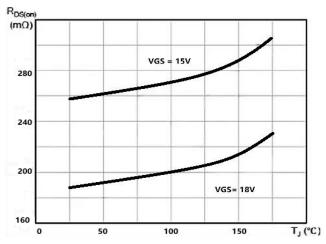


Figure 15. On-Resistance vs. Temperature

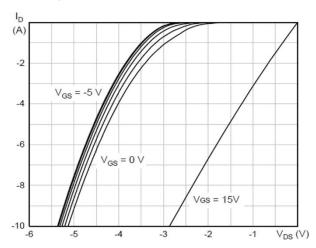


Figure 16. Body Diode Characteristics, T_J = 25°C

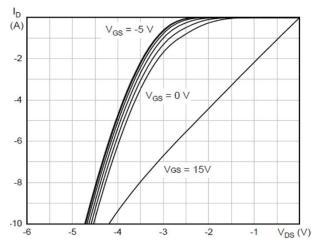
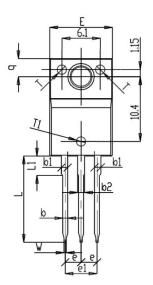


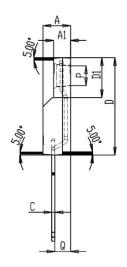
Figure 17. Body Diode Characteristics, T_J = 175°C

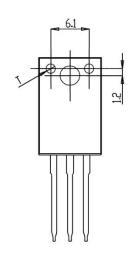


Package Dimensions

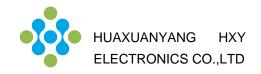
Package TO-220F







SYMBOL	MILLIMETERS		NOTES	SYMBOL	MI	NOTES			
	Normal	MIN.	MAX.	NOTES	SIMBUL	Normal	MIN.	MAX.	NOIES
Α	4.4	4.2	4.6		e1	5.08	5	5.12	
A1	2.7	2.5	2.9		L	13.90	13.5	14.4	
b	0.8	0.7	0.9		L1	3.12	2.8	3.3	
b1	1.07	0.9	1.3		Р	3.14	3.00	3.20	
b2	1.17	1	1.4		Q	2.44	2.3	2.6	
С	0.5	0.4	0.6		q	2.87	2.6	3	
D	15.63	15.4	15.8		W	0.37	0.3	0.5	
D1	6.22	6	6.4		Т	1.52	1.3	1.7	
Ε	10.06	9.7	10.3		T1	1.20	1.1	1.3	
e	2.54	2.5	2.58						



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